Se	arcn	notes	S

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/016,616	GRUENBERG ET AL.	
Examiner	Art Unit	
Pablo Whaley	1631	

[			
SEARCHED			
Class	Subclass	Date	Examiner
			•
	•		
	·		
·			
		•	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

(INCLUDING SEARCH	TES STRATEGY	)
·	DATE	EXMR
EAST: see attached	7/18/2007	PW
Google Scholar: feed concentration, ratio, batch, optimization	7/18/2007	PW
		1
•	٠.	
· .		•